


<b>Search Notes</b>  	<b>Application/Control No.</b>  10780579	<b>Applicant(s)/Patent Under Reexamination</b>  ONOZAWA ET AL.
	<b>Examiner</b>  Duong, Dieu Hien T	<b>Art Unit</b>  2821

SEARCHED			
Class	Subclass	Date	Examiner
315	169.1,169.2,169.3,169.4	01/17/07	dd
345	60	01/17/07	dd

SEARCH NOTES		
Search Notes	Date	Examiner
Please See East Search History	01/17/07	dd
Consulted with David Vu, primary 315	01/17/07	dd

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
315	169.1,169.2,169.3,169.4	01/17/07	dd
345	60	01/17/07	dd